

Search Notes

Application/Control No.

10/727,767

Examiner

Le Nguyen

Applicant(s)/Patent under
Reexamination

DI FRANCO ET AL.

Art Unit

2174

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PG Pub, USPAT: 705/40	7/31/2007	LVN